1996 ASC Abstract

Improved Fabrication of High-Temperature Superconducting-Normal-Superconducting (SNS) Josephson Junctions for Device **Applications** * K.A. DELIN, A.W. KLEINSASSER, J.B. BARNER, and R.P. VASQUEZ, Jet Propulsion Laboratory, California Institute of Technology, Pasadena, CA 91109-8099, USA - The development of a practical high-temperature superconducting (HTS) Josephson technology requires devices with large critical currents, I_c, and normal state resistances, R_n , on appropriate substrate materials. We will present recent results on several process improvements made with the intention of using HTS SNS devices for mixers and digital circuits. We will describe a new means of growing high-quality YBa₂Cu₃O₇ films on silicon-on-sapphire (SOS) substrates without the use of multiple seed layers. This process is used to obtain quality SNS devices on SOS suitable for mixing at frequencies exceeding 1 THz. In addition, we will discuss SNS device experiments involving N interlayers that are more resistive than Co-substituted YBa₂Cu₃O₇, presently the most commonly used interlayer. These more resistive SNS devices are designed to have a higher R_n while maintaining a similar I_c to those junctions currently available.

*Research supported by NASA, BMDO, and NRI.

Presort Category: E-4

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Preference: Poster

I, the registrant for this paper, am willing to review papers in the following subcategories; HTS Junctions, 3-Terminal Devices

L: QUL: (KEVIN DELIN) 1/30/96